

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/085,866 CHEN ET AL.	
		Examiner	Art Unit Shouxian Hu	2811 Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0102799	08-2002	Wawer et al.	438/301
	B	US-2002/0177276	11-2002	Su, Chin-Ta	438/264
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
	O					
	P					
	Q					
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NON-PATENT DOCUMENTS

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